

# TLV785 Lowest-Cost, 500mA, High-PSRR, Fixed, SOT23-5, Low-Dropout Regulator

#### 1 Features

High PSRR: 60dB (1kHz) V<sub>IN</sub> range: 1.4V to 5.5V

Fixed output voltage range: 0.6V to 3.3V

Output voltage accuracy: 2%

Low dropout voltage:

400mV (max) at 500mA (3.3V<sub>OUT</sub>)

Foldback current limit

Active output pulldown resistor

Package:

5-pin SOT-23 (DBV)

## 2 Applications

Wired networking

**Appliances** 

Gaming consoles

Streaming media players

### 3 Description

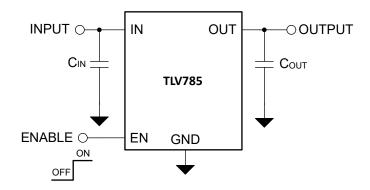
The TLV785 is a small, low-dropout (LDO) linear regulator that sources 500mA of output current. This LDO provides a voltage source with high PSRR and load and line transient performance that meets the requirements for a variety of circuits. The TLV785 has a 1.4V to 5.5V input voltage range and a 0.6V to 3.3V output voltage range. This flexibility makes the device useful for multiple applications.

The TLV785 features an internal soft-start circuit to avoid excessive inrush current, thus minimizing the input voltage drop during start-up. An active pulldown circuit quickly discharges the output when the LDO is disabled and provides a known start-up state. The EN input allows an external logic signal to enable or disable the regulated output. The LDO is stable with small ceramic capacitors, allowing for a small overall package size. The operating junction temperature range is from -40°C to +125°C. This LDO is available in a standard SOT-23 (DBV) package.

#### Package Information

PART NUMBER	PACKAGE <sup>(1)</sup>	PACKAGE SIZE <sup>(2)</sup>
TLV785	DBV (SOT-23, 5)	2.9mm × 2.8mm

- For more information, see the Mechanical, Packaging, and Orderable Information.
- The package size (length × width) is a nominal value and includes pins, where applicable.



**Typical Application Circuit** 



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# 4 Pin Configuration and Functions

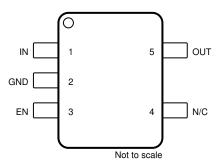


Figure 4-1. DBV Package, 5-Pin SOT-23 (Top View)

# **Table 4-1. Pin Functions**

PIN		TYPE(1)	DESCRIPTION
NAME	SOT-23	1 TPE\"	DESCRIPTION
EN	3	I	Enable input. A low voltage ( $<$ V <sub>EN(LOW)</sub> ) on this pin turns the regulator off and discharges the output pin to GND. A high voltage ( $>$ V <sub>EN(HI)</sub> ) on this pin enables the regulator output.
GND	2	G	Common ground.
IN	1	I	Input voltage supply. For best transient response and to minimize input impedance, use the nominal value or larger capacitor from IN to ground. See the <i>Recommended Operating Conditions table</i> . Place the input capacitor as close to the IN and GND pins of the device as possible.
N/C	4	_	No internal electrical connection. Connect to GND for improved thermal performance.
OUT	5	0	Regulated output voltage. A low equivalent series resistance (ESR) capacitor is required from OUT to ground for stability. For best transient response, use the nominal recommended value or larger capacitor listed in the <i>Recommended Operating Conditions</i> table. Place the output capacitor as close to the OUT and GND pins of the device as possible. An internal pulldown resistor prevents a charge from remaining on $V_{OUT}$ when the regulator is in shutdown mode ( $V_{EN}$ < $V_{EN(LOW)}$ ).

<sup>(1)</sup> I = input, O = output, I/O = input or output, and G = ground.



# **5 Specifications**

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1) (3)

		MIN	MAX	UNIT
	Input, V <sub>IN</sub>	-0.3	6.5	
Voltage	Output, V <sub>OUT</sub>	-0.3	6.0 or V <sub>IN</sub> + 0.3 <sup>(2)</sup>	V
	Enable, V <sub>EN</sub>	-0.3	6.5	
Current	Maximum output, I <sub>OUT</sub> <sup>(4)</sup>	Internall	y limited	А
Temperature	Operating junction, T <sub>J</sub>	<b>–</b> 55	150	°C
remperature	Storage, T <sub>stg</sub>	-65	150	C

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) The maximum value of  $V_{OLIT}$  is the lesser of 6.0V or  $(V_{IN} + 0.3V)$ .
- (3) All voltages are with respect to the GND pin.
- (4) Internal thermal shutdown circuitry protects the device from permanent damage.

# 5.2 ESD Ratings

				VALUE	UNIT
\/		Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±1000	V
V(E	SD)		Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±500	V

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

### 5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	NOM MAX	UNIT
V <sub>IN</sub>	Input supply voltage	1.4	5.5	V
V <sub>EN</sub>	Enable input voltage	0	5.5	V
V <sub>OUT</sub>	Nominal output voltage range	0.6	3.3	V
I <sub>OUT</sub>	Output current	0	500	mA
C <sub>IN</sub>	Input capacitor <sup>(2)</sup>		1	μF
C <sub>OUT</sub>	Output capacitance <sup>(3)</sup>	0.47	40	μF
ESR	Output capacitor effective series resistance		100	mΩ
T <sub>J</sub>	Operating junction temperature	-40	125	°C

- (1) All voltages are with respect to GND.
- (2) An input capacitor is not required for LDO stability. However, an input capacitor with an effective value of 0.47µF minimum is recommended to counteract the effect of source resistance and inductance, which in some cases causes symptoms of system-level instability such as ringing or oscillation, especially in the presence of load transients. A larger input capacitance may be needed depending on the characteristics of the input voltage source.
- (3) Effective output capacitance of 0.47μF minimum and 40μF maximum is required for stability. The effective output capacitance must account for tolerance, temperature, voltage, and any other factors that affect the value, and will often be 50% smaller than the capacitors specified value.

Product Folder Links: TLV785



### **5.4 Thermal Information**

		TLV785	
	THERMAL METRIC <sup>(1)</sup>		
		5 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	242.5	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	140.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	109.4	°C/W
ΨЈТ	Junction-to-top characterization parameter	76.1	°C/W
ΨЈВ	Junction-to-board characterization parameter	108.8	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application note.



### 5.5 Electrical Characteristics

specifications apply for  $T_J$  = 25°C,  $V_{IN}$  =  $V_{OUT(NOM)}$  + 0.5V or 1.4V, whichever is greater,  $V_{EN}$  =  $V_{IN}$ ,  $I_{OUT}$  = 1mA,  $C_{IN}$  = 1µF, and  $C_{OUT}$  = 1µF (unless otherwise noted); all typical values are at  $T_J$  = 25°C

PARAMETER		TEST C	TEST CONDITIONS		TYP	MAX	UNIT		
			0.8V ≤ V <sub>OUT</sub> < 1.8V	-2.5		2.5			
			1.8V ≤ V <sub>OUT</sub> ≤ 3.3V	-2		2	%		
A > 7			0.8V ≤ V <sub>OUT</sub> < 1.2V	-3.33		3.33			
ΔV <sub>OUT</sub>	Output voltage tolerance	T 4000 1 0500	1.2V ≤ V <sub>OUT</sub> < 1.8V	-3		3			
		$T_{J} = -40^{\circ}\text{C to } 85^{\circ}\text{C}$	1.8V ≤ V <sub>OUT</sub> < 2.5V	-2.75		2.75			
			$2.5V \le V_{OUT} \le 3.3V$	-2.5		2.5			
$\Delta V_{OUT} / \Delta V_{IN}$	Line regulation	$V_{IN} = (V_{OUT(NOM)} + 0.5V) to$	5.5V		0.01	0.1	%/V		
ΔV <sub>OUT</sub> / ΔI <sub>OUT</sub>	Load regulation	I <sub>OUT</sub> = 1mA to 500mA <sup>(2)</sup>			125	250	μV/mA		
			$V_{EN} = V_{IN} = 1.6V$		62				
I <sub>GND</sub>	Quiescent ground current	$I_{OUT} = 0$ mA, $T_{J} = -40$ °C to 85°C	$V_{EN} = V_{IN} = 4V$		75		μΑ		
		$V_{EN} = V_{IN} = 5.5V$		80	125				
I <sub>SHDN</sub>	Shutdown ground current	V <sub>EN</sub> < V <sub>EN(LOW)</sub> , V <sub>IN</sub> = 5.5\	/, T <sub>J</sub> = -40°C to 85°C		0.01	2	μA		
			$0.8V \le V_{OUT} < 1.2V^{(1)}$		880	1125			
			$1.2V \le V_{OUT} < 1.8V^{(1)}$		690	725	10 25 00 mV		
	/ <sub>DO</sub> Dropout voltage	$I_{OUT} = 500 \text{mA},$ $V_{IN} = V_{OUT(NOM)}$	1.8V ≤ V <sub>OUT</sub> < 2.5V		530	710			
		- 114	2.5V ≤ V <sub>OUT</sub> < 2.8V		350	425			
,,			$2.8V \le V_{OUT} \le 3.3V$		330	400			
v <sub>DO</sub>			$0.8V \le V_{OUT} < 1.2V^{(1)}$		880	1215			
		I <sub>OUT</sub> = 500mA,	$1.2V \le V_{OUT} < 1.8V^{(1)}$		690	820			
		$V_{IN} = V_{OUT(NOM)},$ $T_{J} = -40^{\circ}\text{C to } 85^{\circ}\text{C}$	1.8V ≤ V <sub>OUT</sub> < 2.5V		530	820			
		$T_J = -40^{\circ}$ C to 85°C	2.5V ≤ V <sub>OUT</sub> < 2.8V		350	495			
			$2.8V \le V_{OUT} \le 3.3V$		330	470	)		
I <sub>CL</sub>	Output current limit	$V_{OUT} = 0.9 \times V_{OUT(NOM)}, T_{OUT(NOM)} + 1V$	$_{\rm J}$ = -40°C to 85°C, $V_{\rm IN}$ =	550		900	mA		
I <sub>SC</sub>	Short-circuit current limit	V <sub>OUT</sub> = 0V			180		mA		
			f = 1kHz		60				
PSRR	Power-supply rejection ratio	I <sub>OUT</sub> = 150mA, V <sub>IN</sub> = V <sub>OUT</sub> + 1.0V	f = 100kHz		56		dB		
		VIN - VOUT : 1.0V	f = 1MHz		45				
V <sub>N</sub>	Output noise voltage	BW = 10Hz to 100kHz, I <sub>OL</sub>	<sub>JT</sub> = 50mA	7	5 × Vout		μV <sub>RMS</sub>		
R <sub>PULLDOWN</sub>	Output automatic discharge pulldown resistance	V <sub>EN</sub> < V <sub>EN(LOW)</sub> (output dis	V <sub>EN</sub> < V <sub>EN(LOW)</sub> (output disabled), V <sub>IN</sub> = 3.3V		135		Ω		
т.	Th	T <sub>J</sub> rising		T <sub>J</sub> rising			160		*^
$T_{SD}$	Thermal shutdown	T <sub>J</sub> falling			140		°C		
V <sub>EN(LOW)</sub>	EN pin low (disabled)	T <sub>J</sub> = -40°C to 85°C		0		0.3	V		
V <sub>EN(HI)</sub>	EN pin high (enabled)	T <sub>J</sub> = -40°C to 85°C		0.9		5.5	V		
I <sub>EN</sub>	EN input leakage current	V <sub>EN</sub> = 5.5V and V <sub>IN</sub> = 5.5V	,		0.01	1	μA		

<sup>(1)</sup> For  $V_{OUT}$  < 1.6V, dropout is tested with  $V_{IN}$  = 1.6V.

# **5.6 Switching Characteristics**

specifications apply for  $T_J$  = 25°C,  $V_{IN}$  =  $V_{OUT(NOM)}$  + 0.5V or 1.4V, whichever is greater,  $V_{EN}$  =  $V_{IN}$ ,  $I_{OUT}$  = 1mA,  $C_{IN}$  = 1 $\mu$ F, and  $C_{OUT}$  = 1 $\mu$ F (unless otherwise noted); all typical values are at  $T_J$  = 25°C

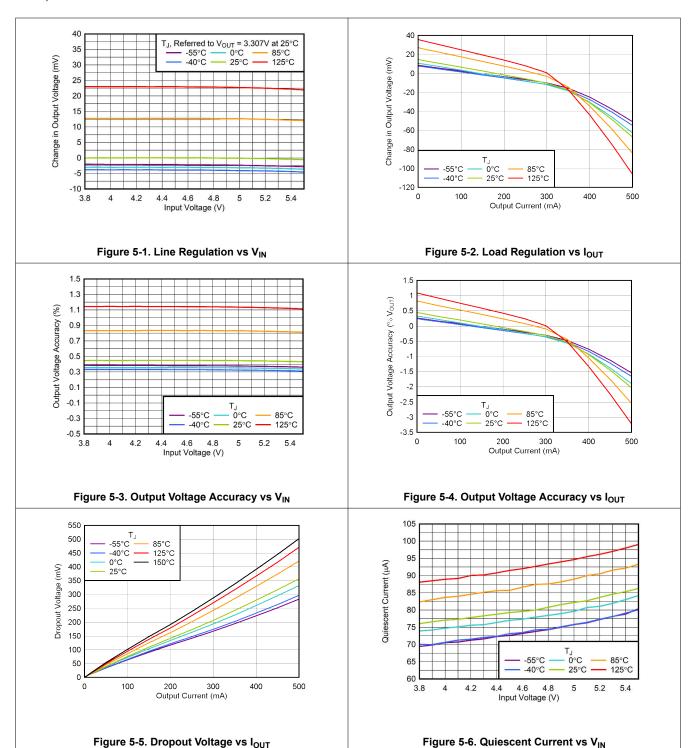
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>STR</sub>	Start-up time (V <sub>EN</sub> )	From V <sub>EN</sub> > V <sub>EN(HI)</sub> to V <sub>OUT</sub> = 95% of V <sub>OUT(NOM)</sub> , V <sub>IN</sub> rise time = 1V/ $\mu$ s		400		μs

Product Folder Links: TLV785

<sup>(2)</sup> Load regulation not tested in dropout.

### **5.7 Typical Characteristics**

at operating temperature  $T_J$  = 25°C,  $V_{IN}$  =  $V_{OUT(NOM)}$  + 0.5V,  $I_{OUT}$  = 1mA,  $V_{EN}$  =  $V_{IN}$ , and  $C_{IN}$  =  $C_{OUT}$  = 1 $\mu$ F (unless otherwise noted)





## **5.7 Typical Characteristics (continued)**

at operating temperature  $T_J$  = 25°C,  $V_{IN}$  =  $V_{OUT(NOM)}$  + 0.5V,  $I_{OUT}$  = 1mA,  $V_{EN}$  =  $V_{IN}$ , and  $C_{IN}$  =  $C_{OUT}$  = 1 $\mu$ F (unless otherwise noted)

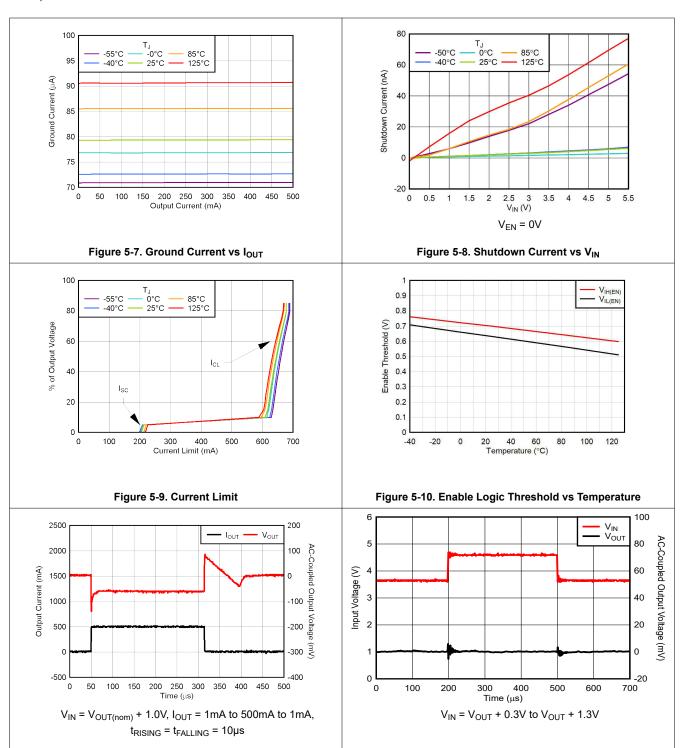
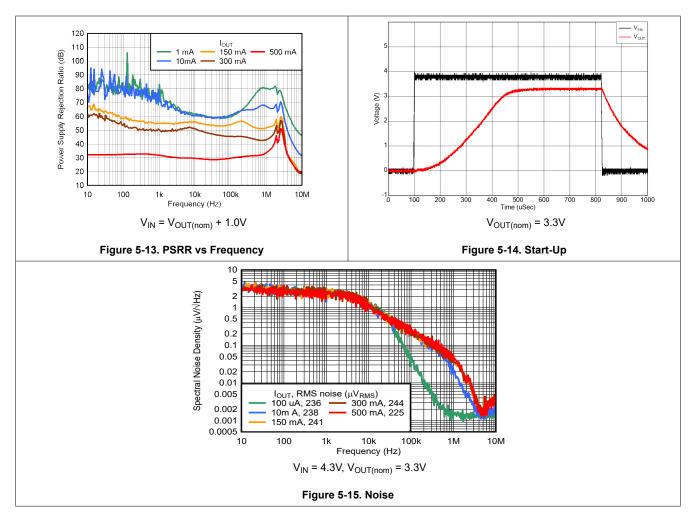


Figure 5-11. Load Transient

Figure 5-12. Line Transient

# **5.7 Typical Characteristics (continued)**

at operating temperature  $T_J$  = 25°C,  $V_{IN}$  =  $V_{OUT(NOM)}$  + 0.5V,  $I_{OUT}$  = 1mA,  $V_{EN}$  =  $V_{IN}$ , and  $C_{IN}$  =  $C_{OUT}$  = 1 $\mu$ F (unless otherwise noted)





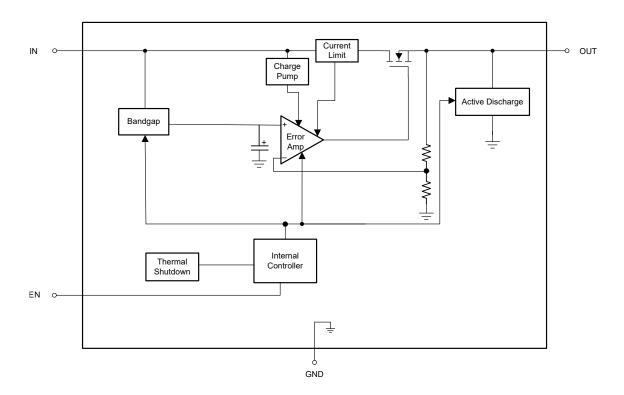
# **6 Detailed Description**

#### 6.1 Overview

The TLV785 provides high PSRR and good transient response in a small 500mA LDO.

This LDO is designed to operate with a single 1µF input capacitor and a single 1µF ceramic output capacitor.

### 6.2 Functional Block Diagram



#### **6.3 Feature Description**

#### 6.3.1 Dropout Voltage

Dropout voltage  $(V_{DO})$  is defined as  $V_{IN} - V_{OUT}$  at the rated output current  $(I_{RATED})$ , where the pass transistor is fully on.  $V_{IN}$  is the input voltage,  $V_{OUT}$  is the output voltage, and  $I_{RATED}$  is the maximum  $I_{OUT}$  listed in the *Recommended Operating Conditions* table. At this operating point, the pass transistor is driven fully on. Dropout voltage indirectly specifies a minimum input voltage greater than the nominal programmed output voltage where the output voltage is expected to stay in regulation. If the input voltage falls to less than the nominal output regulation, then the output voltage falls as well.

For a CMOS regulator, the dropout voltage is determined by the drain-source, on-state resistance ( $R_{DS(ON)}$ ) of the pass transistor. Therefore, if the linear regulator operates at less than the rated current, the dropout voltage for that current scales accordingly. The following equation calculates the  $R_{DS(ON)}$  of the device.

$$R_{DS(ON)} = \frac{V_{DO}}{I_{RATED}}$$
 (1)

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#### 6.3.2 Active Discharge

The regulator has an internal MOSFET that connects a pulldown resistor between the output and ground when the device is disabled. This connection actively discharges the output voltage. The active discharge circuit is activated by the enable pin or by the voltage on IN falling below the undervoltage lockout (UVLO) threshold.

Do not rely on the active discharge circuit for discharging a large amount of output capacitance after the input supply collapses. Reverse current flow from the output to the input potentially causes damage to the device. Limit reverse current to no more than 5% of the device rated current for a short period of time.

#### 6.3.3 Foldback Current Limit

The device has an internal current limit circuit that protects the regulator during transient high-load current faults or shorting events. The current limit is a hybrid brick-wall-foldback scheme. The current limit transitions from a brick-wall scheme to a foldback scheme at the foldback voltage ( $V_{FOLDBACK}$ ). In a high-load current fault with the output voltage above  $V_{FOLDBACK}$ , the brick-wall scheme limits the output current to the current limit ( $I_{CL}$ ). When the voltage drops below  $V_{FOLDBACK}$ , a foldback current limit activates that scales back the current when the output voltage approaches GND. When the output is shorted, the device supplies a typical current termed the *short-circuit current limit* ( $I_{SC}$ ).  $I_{CL}$  and  $I_{SC}$  are listed in the *Electrical Characteristics* table.

The output voltage is not regulated when the device is in current limit. When a current limit event occurs, the device begins to heat up because of the increase in power dissipation. When the device is in brick-wall current limit, the pass transistor dissipates power  $[(V_{IN} - V_{OUT}) \times I_{CL}]$ . When the device output is shorted and the output is below  $V_{FOLDBACK}$ , the pass transistor dissipates power  $[(V_{IN} - V_{OUT}) \times I_{SC}]$ . If thermal shutdown is triggered, the device turns off. After the device cools down, the internal thermal shutdown circuit turns the device back on. If the output current fault condition continues, the device cycles between current limit and thermal shutdown. For more information on current limits, see the *Know Your Limits* application note.

Figure 6-1 shows a diagram of the foldback current limit.

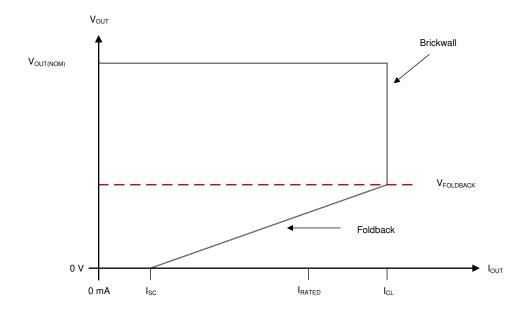


Figure 6-1. Foldback Current Limit



#### 6.3.4 Thermal Shutdown

The device contains a thermal shutdown protection circuit to disable the device when the junction temperature  $(T_J)$  of the pass transistor rises to  $T_{SD(shutdown)}$  (typical). Thermal shutdown hysteresis makes sure that the device resets (turns on) when the temperature falls to  $T_{SD(reset)}$  (typical).

The thermal time-constant of the semiconductor die is fairly short. Thus the device cycles on and off when thermal shutdown is reached until power dissipation is reduced. Power dissipation during start-up is high from large  $V_{\text{IN}} - V_{\text{OUT}}$  voltage drops across the device or from high inrush currents charging large output capacitors. Under some conditions, the thermal shutdown protection disables the device before start-up completes.

For reliable operation, limit the junction temperature to the maximum listed in the *Recommended Operating Conditions* table. Operation above this maximum temperature causes the device to exceed operational specifications. Although the device internal protection circuitry is designed to protect against thermal overload conditions, this circuitry is not intended to replace proper heat sinking. Continuously running the device into thermal shutdown or above the maximum recommended junction temperature reduces long-term reliability.

#### 6.4 Device Functional Modes

Table 6-1 shows the conditions that lead to the different modes of operation. See the *Electrical Characteristics* table for parameter values.

Table 6-1. Device Functional Mode Comparison
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· · · · · · · · · · · · · · · · · · ·							
OPERATING MODE	PARAMETER						
OPERATING WIDDE	V <sub>IN</sub>	V <sub>EN</sub>	I <sub>OUT</sub>	T <sub>J</sub>			
Normal operation	$V_{IN} > V_{OUT(nom)} + V_{DO}$ and $V_{IN} > V_{IN(min)}$	V <sub>EN</sub> > V <sub>EN(HI)</sub>	$I_{OUT} < I_{OUT(max)}$	T <sub>J</sub> < T <sub>SD(shutdown)</sub>			
Dropout operation	$V_{IN(min)} < V_{IN} < V_{OUT(nom)} + V_{DO}$	V <sub>EN</sub> > V <sub>EN(HI)</sub>	I <sub>OUT</sub> < I <sub>OUT(max)</sub>	T <sub>J</sub> < T <sub>SD(shutdown)</sub>			
Disabled (any true condition disables the device)	V <sub>IN</sub> < V <sub>UVLO</sub>	V <sub>EN</sub> < V <sub>EN(LOW)</sub>	Not applicable	$T_{J} > T_{SD(shutdown)}$			

#### 6.4.1 Normal Operation

The device regulates to the nominal output voltage when the following conditions are met:

- The input voltage is greater than the nominal output voltage plus the dropout voltage (V<sub>OUT(nom)</sub> + V<sub>DO</sub>)
- The output current is less than the current limit (I<sub>OUT</sub> < I<sub>CL</sub>)
- The device junction temperature is less than the thermal shutdown temperature (T<sub>.I</sub> < T<sub>SD</sub>)
- The enable voltage has previously exceeded the enable rising threshold voltage and has not yet decreased to less than the enable falling threshold

#### 6.4.2 Dropout Operation

If the input voltage is lower than the nominal output voltage plus the specified dropout voltage, the device operates in dropout mode. In this mode, the output voltage tracks the input voltage. In this mode, the transient performance of the device becomes significantly degraded. During this mode, the pass transistor is driven fully on. Line or load transients in dropout potentially result in large output voltage deviations.

When the device is in a steady dropout state, the pass transistor is driven fully on. This state is defined as when the device is in dropout, directly after being in a normal regulation state, but *not* during start-up. Dropout occurs when  $V_{IN} < V_{OUT(NOM)} + V_{DO}$ . When the regulator exits dropout, the input voltage returns to a value  $\geq V_{OUT(NOM)} + V_{DO}$ . During this time, the output voltage potentially overshoots for a short period of time.  $V_{OUT(NOM)}$  is the nominal output voltage and  $V_{DO}$  is the dropout voltage. During dropout exit, the device pulls the pass transistor back from being driven fully on.

#### 6.4.3 Disabled

Shutdown the device output by forcing the enable pin voltage to less than the maximum EN pin low-level input voltage (see the *Electrical Characteristics* table). When disabled, the pass transistor turns off and internal circuits shut down. The output voltage is also actively discharged to ground by an internal discharge circuit from the output to ground.

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# 7 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

## 7.1 Application Information

### 7.1.1 Recommended Capacitor Types

The device is designed to be stable using low equivalent series resistance (ESR) ceramic capacitors at the input and output. Multilayer ceramic capacitors have become the industry standard for these types of applications and are recommended, but use good judgment. Ceramic capacitors that employ X7R-, X5R-, and C0G-rated dielectric materials provide relatively good capacitive stability across temperature. However, using Y5V-rated capacitors is discouraged because of large variations in capacitance.

Regardless of the ceramic capacitor type selected, the effective capacitance varies with operating voltage and temperature. Generally, expect the effective capacitance to decrease by as much as 50%. The input and output capacitors listed in the *Recommended Operating Conditions* table account for an effective capacitance of approximately 50% of the nominal value.

### 7.1.2 Input and Output Capacitor Requirements

Although an input capacitor is not required for stability, good analog design practice is to connect a capacitor from IN to GND. This capacitor counteracts reactive input sources and improves transient response, input ripple, and PSRR. Use an input capacitor if the source impedance is more than  $0.5\Omega$ . For typical operation of the TLV785, connect a 1 $\mu$ F capacitor to the input. Use a higher value capacitor if large, fast rise-time, load, or line transients are anticipated. Additionally, use a higher-value capacitor if the device is located several inches from the input power source.

Dynamic performance of the device is improved by using an output capacitor. Use an output capacitor within the range specified in the *Recommended Operating Conditions* table for stability. Make sure that the minimum derated output capacitance is equal to or greater than 0.47µF. When the output voltage is ramping up, the inrush current depends on the size of the output capacitance. During start-up, the output current is potentially as high as the current limit value for larger output capacitors.

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Product Folder Links: TLV785

### 7.2 Typical Application

### 7.2.1 Application

Figure 7-1 shows a typical application circuit for the TLV785.

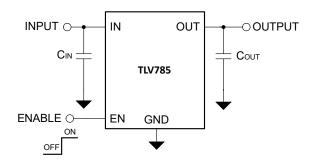


Figure 7-1. TLV785 Typical Application

#### 7.2.2 Design Requirements

Table 7-1 summarizes the design requirements for Figure 7-1.

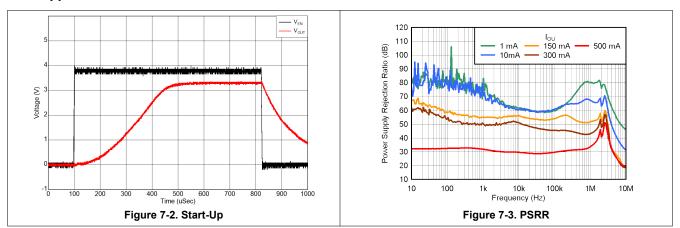
Table 7-1. Design Parameters

PARAMETER	VALUE
Input voltage range	4.0V ± 5%
Output voltage	3.3V
Output current	200mA
Maximum ambient temperature	85°C

#### 7.2.3 Detailed Design Procedure

For this design example, the 3.3V output version (TLV78533) is selected. A nominal 4.0V input supply is assumed. Use a minimum  $1\mu F$  input capacitor to minimize the effect of resistance and inductance between the 4.0V source and LDO input. Use a minimum  $0.47\mu F$  output capacitance for stability and good load transient response. The dropout voltage ( $V_{DO}$ ) is less than 470mV maximum at a 3.3V output voltage and 500mA output current. Thus, there are no dropout issues with a minimum input voltage of 3.8V and a maximum output current of 200mA. The minimum input voltage is calculated at 4.0V - 5%.

#### 7.2.4 Application Curves





### 7.3 Power Supply Recommendations

This device is designed to operate from an input supply voltage range of 1.4V to 5.5V. Make sure the input is well regulated and free of spurious noise, so the regulator provides a well regulated output with optimum dynamic performance. Set the input supply to at least  $V_{OUT(nom)} + 0.5V$  or 1.4V, whichever is greater.

Use a 1µF or greater input capacitor to reduce the impedance of the input supply, especially during transients.

# 7.4 Layout

### 7.4.1 Layout Guidelines

- Place input and output capacitors as close to the device as possible.
- Use copper planes for device connections to optimize thermal performance.
- · Place thermal vias around the device to distribute heat.

#### 7.4.2 Layout Example

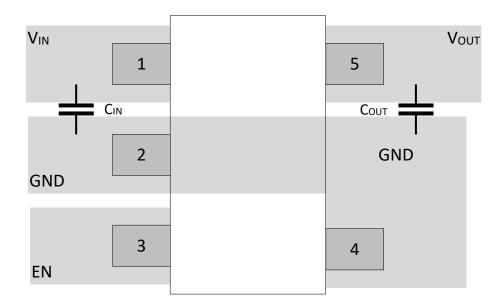


Figure 7-4. DBV Package (SOT-23) Typical Layout

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# 8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed in this section.

### 8.1 Documentation Support

#### 8.1.1 Related Documentation

For related documentation, see the following:

• Texas Instruments, Know Your Limits application note

#### 8.1.2 Device Nomenclature

**Table 8-1. Device Nomenclature** 

PRODUCT <sup>(1)</sup>	DESCRIPTION
TLV785 <b>xx(x)(P)yyyz</b>	<ul> <li>xx(x) is the nominal output voltage. For output voltages with a resolution of 100mV, two digits are used in the ordering number. Otherwise, three digits are used (for example, 28 = 2.8V; 125 = 1.25V).</li> <li>(P) indicates an active output discharge feature.</li> <li>yyy is the package designator.</li> <li>z is the package quantity. R is for a standard reel, J is for a jumbo reel.</li> </ul>

<sup>(1)</sup> For the most current package and ordering information see the Package Option Addendum at the end of this document, or visit the device product folder on <a href="https://www.ti.com">www.ti.com</a>.

### 8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

## 8.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 8.4 Trademarks

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### 8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 8.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.



## **9 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision B (August 2025) to Revision C (October 2025)					
Changed 1.8V over temperature dropout max spec	6				
Changes from Revision A (June 2025) to Revision B (August 2025)	Page				
Changed 2.5V over temperature dropout max spec					
Changes from Revision * (February 2025) to Revision A (June 2025)	Page				
Changed document status from Advance Information to Production Data	1				

# 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
TLV78518PDBVR	Active	Production	SOT-23 (DBV)   5	3000   JUMBO T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3RKH
TLV78525PDBVR	Active	Production	SOT-23 (DBV)   5	3000   JUMBO T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3RJH
TLV78528PDBVR	Active	Production	SOT-23 (DBV)   5	3000   JUMBO T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3RIH
TLV78530PDBVR	Active	Production	SOT-23 (DBV)   5	3000   JUMBO T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3RPH
TLV78533PDBVR	Active	Production	SOT-23 (DBV)   5	3000   JUMBO T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3NBH

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

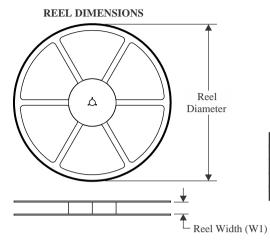
<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

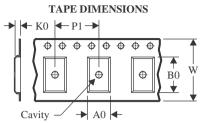
# **PACKAGE MATERIALS INFORMATION**

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### TAPE AND REEL INFORMATION

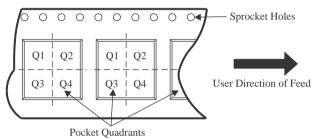
NSTRUMENTS





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

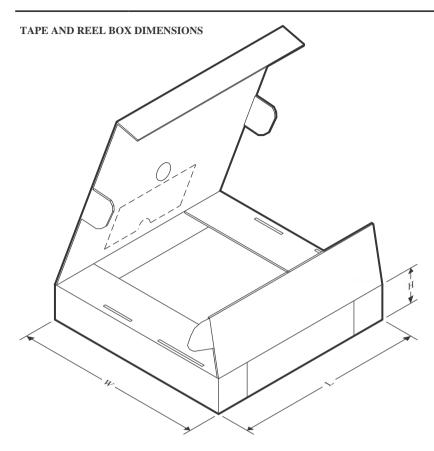


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLV78518PDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
TLV78525PDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
TLV78528PDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
TLV78530PDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
TLV78533PDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3



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#### \*All dimensions are nominal

7 III GIIII GII GII GII GII GII GII GII							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLV78518PDBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
TLV78525PDBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
TLV78528PDBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
TLV78530PDBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
TLV78533PDBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0



SMALL OUTLINE TRANSISTOR



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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